

FDMS86500L N-Channel PowerTrench[®] MOSFET 60 V, 80 A, 2.5 m Ω

Features

- Max $r_{DS(on)}$ = 2.5 m Ω at V_{GS} = 10 V, I_D = 25 A
- Max $r_{DS(on)} = 3.7 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 20 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

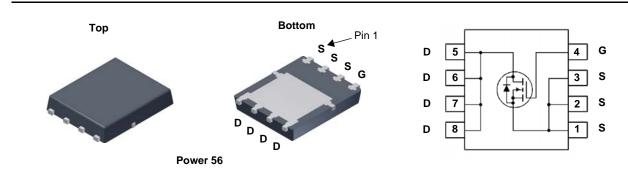


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- Primary Switch in isolated DC-DC
- Synchronous Rectifier
- Load Switch



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			60	V
V _{GS}	Gate to Source Voltage			±20	V
ID	Drain Current -Continuous (Package limited)	T _C = 25 °C	(Note 4)	80	
	-Continuous (Silicon limited)	T _C = 25 °C		158	
	-Continuous	T _A = 25 °C	(Note 1a)	25	— A
	-Pulsed			180	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	240	mJ
P _D	Power Dissipation	T _C = 25 °C		104	14/
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 50	C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86500L	FDMS86500L	Power 56	13 "	12 mm	3000 units

September 2011

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	V_{DSS} Drain to Source Breakdown Voltage $I_{\text{D}} = 250 \ \mu\text{A}, V_{\text{GS}} = 0 \ \text{V}$		60			V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		30		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	1	1.8	3	V
$\Delta V_{GS(th)}$	Gate to Source Threshold Voltage	$I_D = 250 \ \mu$ A, referenced to 25 °C		-7		mV/°C
ΔT_{J}	Temperature Coefficient					
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 25 A		2.1	2.5	-
		$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		2.9	3.7	mΩ
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 25 \text{ A}, \text{ T}_{J} = 125 \text{ °C}$ $V_{DS} = 5 \text{ V}, \text{ I}_{D} = 20 \text{ A}$		3.1 95	3.7	S
9 _{FS}	Characteriation			1		
	Characteristics			0.400	40500	- 5
C _{iss}	Input Capacitance	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		9420	12530	pF
C _{oss}	Output Capacitance Reverse Transfer Capacitance	f = 1 MHz		1470 50	1955 80	pF
C _{rss}	Reverse Transfer Capacitance					
					80	pF
R _g	Gate Resistance			1.1	80	ρF
					80	
Switching	Gate Resistance				43	
Switching t _{d(on)}	Gate Resistance g Characteristics	V _{DD} = 30 V, I _D = 25 A,		1.1		Ω
Switching t _{d(on)}	Gate Resistance g Characteristics Turn-On Delay Time	$V_{DD} = 30 \text{ V}, \text{ I}_D = 25 \text{ A},$ V _{GS} = 10 V, R _{GEN} = 6 Ω		1.1	43	Ω
Switching t _{d(on)} t _r t _{d(off)}	Gate Resistance g Characteristics Turn-On Delay Time Rise Time			1.1 27 16	43 28	Ω ns ns
Switching t _{d(on)} t _r t _{d(off)} t _f	Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$		1.1 27 16 63	43 28 100	Ω ns ns ns
Switching t _{d(on)} t _r t _{d(off)} t _f Q _g	Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$		1.1 27 16 63 7.8	43 28 100 16	Ω ns ns ns ns
Switching t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		1.1 27 16 63 7.8 117	43 28 100 16 165	Ω ns ns ns nC
Switching $t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_g Q_g	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$		1.1 27 16 63 7.8 117 54	43 28 100 16 165	Ω ns ns ns nc
Switching t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g Q _{gs} Q _{gd}	Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$		1.1 27 16 63 7.8 117 54 26.6	43 28 100 16 165	Ω ns ns ns ns nc nC nC
Switching $t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_g Q_{gs} Q_{gd} Drain-Sou	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge urce Diode Characteristics	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 30 \text{ V},$ $I_{D} = 25 \text{ A}$		1.1 27 16 63 7.8 117 54 26.6	43 28 100 16 165	Ω ns ns ns nC nC nC
Switching $t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_g Q_{gs} Q_{gd} Drain-Sou	Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 30 \text{ V},$ $I_{D} = 25 \text{ A}$		1.1 27 16 63 7.8 117 54 26.6 11.5	43 28 100 16 165 108	Ω ns ns ns ns nc nC nC
Switching $t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_g Q_g Q_{gs} Q_{gd} Drain-Sou V_{SD}	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge urce Diode Characteristics	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 30 \text{ V},$ $I_D = 25 \text{ A}$ $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A} \text{ (Note 2)}$ $V_{GS} = 0 \text{ V}, I_S = 25 \text{ A} \text{ (Note 2)}$		1.1 27 16 63 7.8 117 54 26.6 11.5 0.68	43 28 100 16 165 108 	Ω ns ns ns nC nC nC
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g Q _{gs} Q _{gd}	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge urce Diode Characteristics Source to Drain Diode Forward Voltage	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 30 \text{ V},$ $I_D = 25 \text{ A}$ $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)		1.1 27 16 63 7.8 117 54 26.6 11.5 0.68 0.79	43 28 100 16 165 108 	Ω ns ns ns nc nC nC NC NC
Switching t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g Q _g Q _{gd} Drain-Sou V _{SD} t _{rr}	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge urce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 30 \text{ V},$ $I_D = 25 \text{ A}$ $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A} \text{ (Note 2)}$ $V_{GS} = 0 \text{ V}, I_S = 25 \text{ A} \text{ (Note 2)}$		1.1 27 16 63 7.8 117 54 26.6 11.5 0.68 0.79 54	43 28 100 16 165 108 	Ω ns ns ns nC nC nC nC v

Notes: 1. R_{0,JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



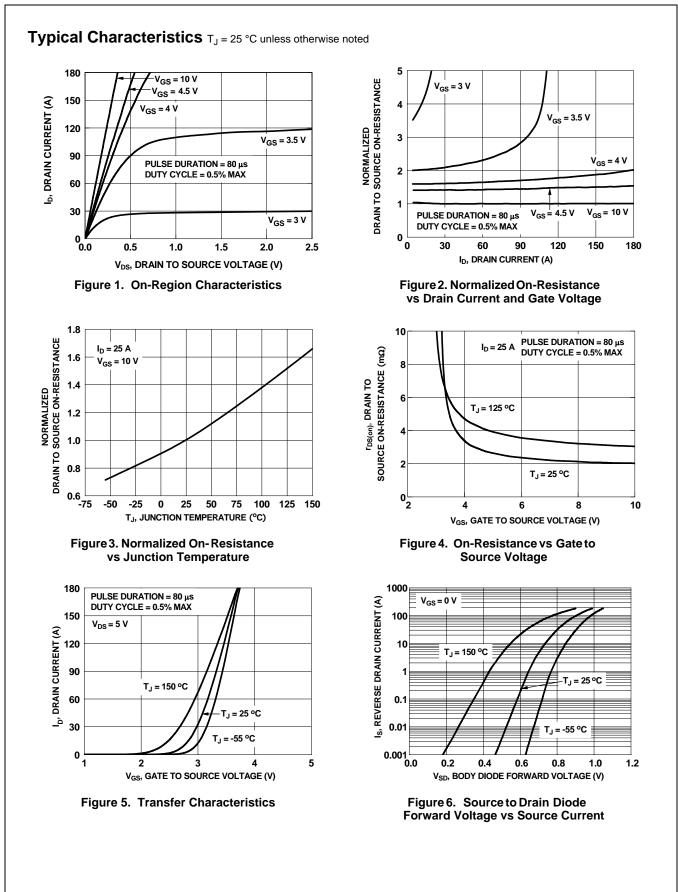
a) 50 °C/W when mounted on a 1 in² pad of 2 oz copper

b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

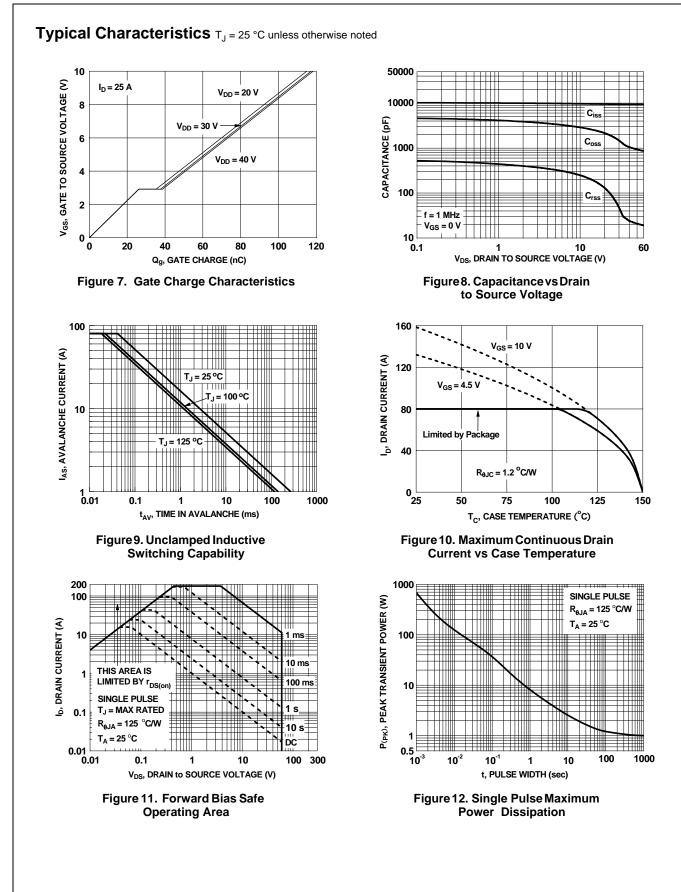
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2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. E_{AS} of tbd mJ is based on starting T_J = 25 °C, L = 0.3 mH, I_{AS} = 40 A, V_{DD} = 54 V, V_{GS} = 10 V.

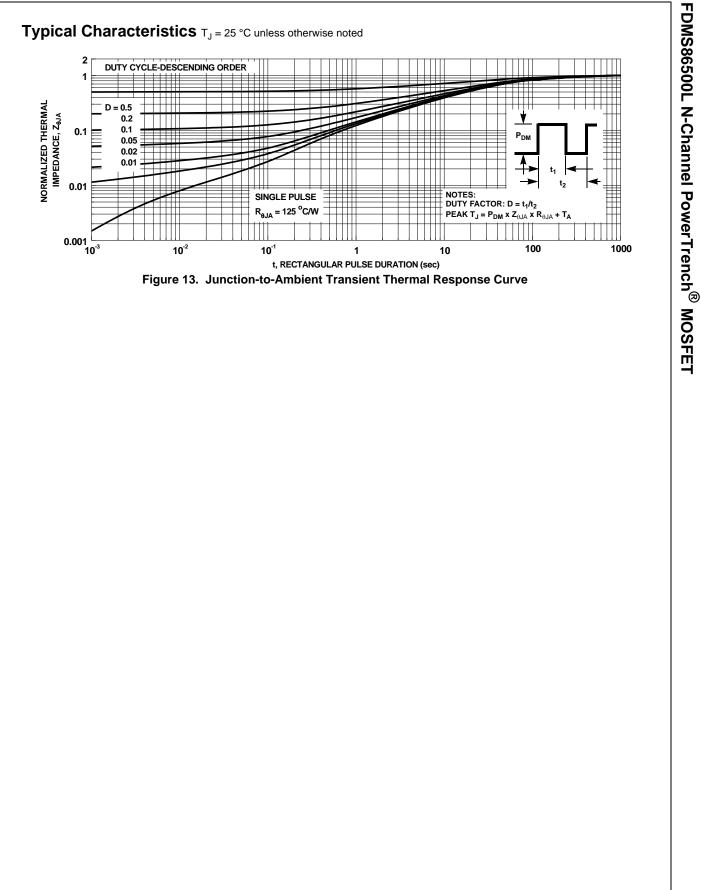
4. Package-limited current of 80 A is based on ideal infinite heatsink condition.

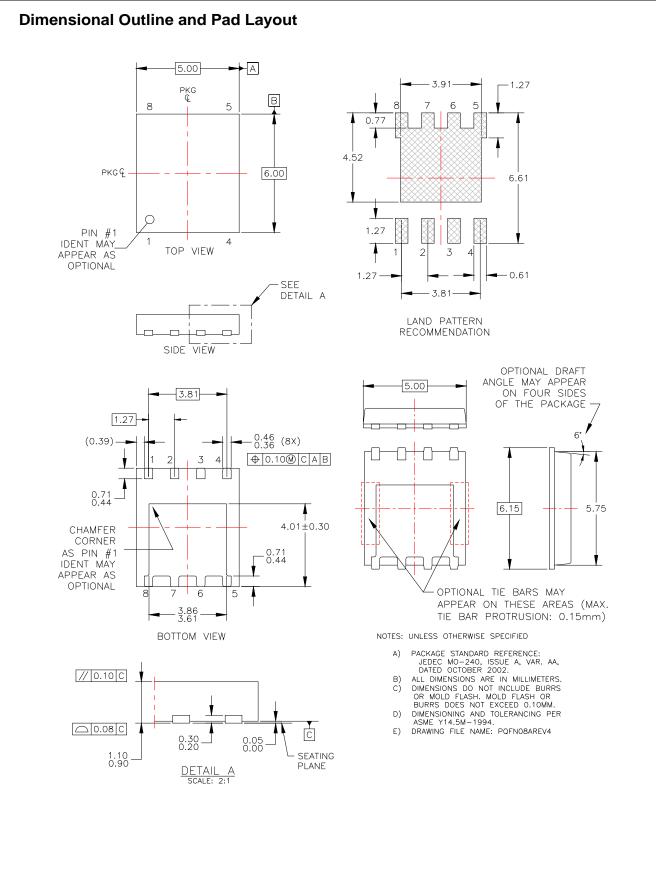






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FDMS86500L N-Channel PowerTrench[®] MOSFET



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